2.5V Drive Pch+SBD MOS FET

QS5U28

Structure

Silicon P-channel MOS FET Schottky Barrier DIODE

● Features

- 1) The QS5U28 combines Pch MOS FET with a Schottky barrier diode in TSMT5 package.
- 2) Low on-state resistance with fast switching.
- 3) Low voltage drive (2.5V).
- 4) Built-in schottky barrier diode has low forward voltage.

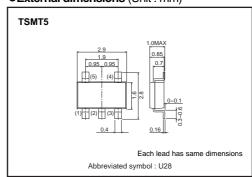
Applications

Load switch, DC/DC conversion

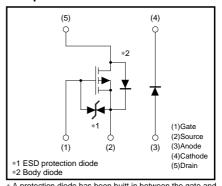
Packaging specifications

	Package	Taping
Туре	Code	TR
,,	Basic ordering unit (pieces)	3000
QS5U28		0

●External dimensions (Unit : mm)



●Equivalent circuit



* A protection diode has been buitt in between the gate and the source to protect against static electricity when the product is in use. Use the protection circuit when rated voltages are exceeded.

●Absolute maximum ratings (Ta=25°C)

<MOSFET>

Parameter		Symbol	Limits	Unit
Drain-source voltage		Voss	-20	V
Gate-source voltage		Vgss	±12	V
Drain current	Continuous	lσ	±2.0	Α
Diain current	Pulsed	IDP*1	±8.0	Α
Source current	Continuous	Is	-1.0	Α
(Body diode)	Pulsed	Isp*1 -8.0		Α
Channel temperature		Tch	150	°C
Power dispation		P _D *3	0.9	W/ELEMENT
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Parameter		Symbol	Limits	Unit
Repetitive peak reverse voltage		V _{RM}	25	V
Reverse voltage		VR	20	V
= :			4.0	

Tarameter	Cyllibol	Limito	OTIL
Repetitive peak reverse voltage	V _{RM}	25	V
Reverse voltage	VR	20	V
Forward current	lF	1.0	А
Forward current surge peak	IFSM*2	3.0	Α
Junction temperature	Tj	150	°C
Power dispation	P _D *3	0.7	W/ELEMENT

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Parameter	Symbol	Limits	Unit
Total power dispation	P _D *3	1.25	W/TOTAL
Range of strage temperature	Tstg	-55 to +150	°C

^{*1} Pw≤10μs, Duty cycle≤1% *2 60Hz •1cyc. *3 Mounted on a ceramic board.

●Electrical characteristics (Ta=25°C)

<MOSFET>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	Igss	-	-	±10	μΑ	Vgs= ±12V, Vps= 0V
Drain-source breakdown voltage	V(BR) DSS	-20	-	_	V	I _D = -1mA, V _G s= 0V
Zero gate voltage drain current	IDSS	ı	ı	-1	μΑ	V _{DS} = -20V, V _{GS} = 0V
Gate threshold voltage	VGS (th)	-0.7	-	-2.0	V	V _{DS} = -10V, I _D = -1mA
Otatia daria arrana an atauta		_	90	125	mΩ	I _D = -2A, V _G s= -4.5V
Static drain-source on-starte resistance	RDS (on)*	_	97	135	mΩ	I _D = -2A, V _G s= -4.0V
resistance		ı	175	245	mΩ	I _D = -1A, V _G s= -2.5V
Forward transfer admittance	Yfs *	1.6	-	_	S	V _{DS} = -10V, I _D = -1A
Input capacitance	Ciss	_	450	_	pF	V _{DS} = -10V
Output capacitance	Coss	1	70	-	pF	VGS= 0V
Reverse transfer capacitance	Crss	_	52	_	рF	f=1MHz
Turn-on delay time	td (on) *	ı	10	-	ns	V _{DD}
Rise time	tr *	_	16	_	ns	Vgs= -4.5V ID= -1A
Turn-off delay time	td (off) *	ı	32	-	ns	ID= -1A RL= 15Ω
Fall time	tf *	_	15	_	ns	R _G = 10Ω
Total gate charge	Qg *	ı	4.8	-	nC	V _{DD} = −15V V _{GS} = −4.5V
Gate-source charge	Qgs *	_	1.0	_	nC	ID= -2A
Gate-drain charge	Q _{gd} *	_	1.3	-	nC	R_L = 7.5 Ω R_G = 10 Ω

^{*} Pulsed

<MOSFET> Body diode (Source-drain)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	Vsp	_	-	-1.2	V	Is= -1.0V , Vgs= 0V

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Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	VF	-	-	0.45	V	IF= -1.0V
Reverse current	lR	_	_	200	μA	V _R = 20V

•Electrical characteristic curves

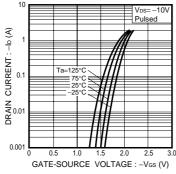


Fig.1 Typical Transfer Characteristics

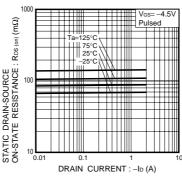


Fig.2 Static Drain-Source On-State Resistance vs. Drain Current (I)

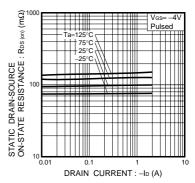


Fig.3 Static Drain-Source On-State Resistance vs. Drain Current (II)

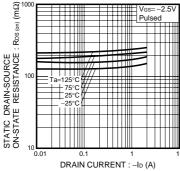


Fig.4 Static Drain-Source On-State Resistance vs. Drain Current (III)

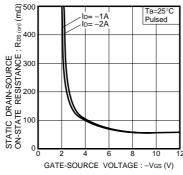


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

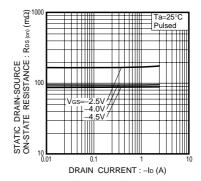


Fig.6 Static Drain-Source On-State Resistance vs. Drain Current

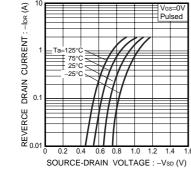


Fig.7 Reverse Drain Current vs. Source-Drain Voltage

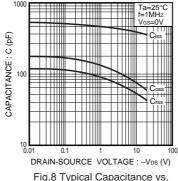


Fig.8 Typical Capacitance vs. Drain-Source Voltage

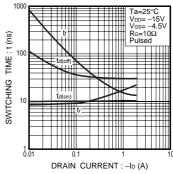


Fig.9 Switching Characteristics

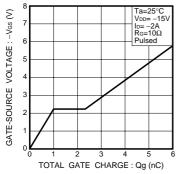


Fig.10 Dynamic Input Characteristics

Measurement circuits

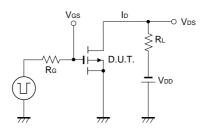


Fig.11 Switching Time Measurement Circuit

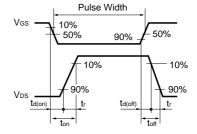


Fig.12 Switching Waveforms

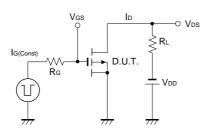


Fig.13 Gate Charge Measurement Circuit

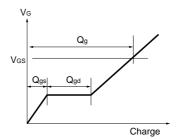


Fig.14 Gate Charge Waveforms

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